HALOGEN

FREE





Dual N-Channel 30 V (D-S) MOSFETs

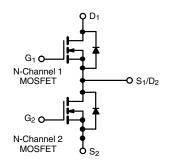
PRODUCT SUMMARY						
	V _{DS} (V)	$R_{DS(on)}$ (Ω) (Max.)	I _D (A)	Q _g (Typ.)		
Channel-1	30	0.0058 at $V_{GS} = 10 \text{ V}$	40 ^a	12.5 nC		
		0.0075 at $V_{GS} = 4.5 \text{ V}$	40 ^a	12.5110		
Channel-2	30	0.0030 at V _{GS} = 10 V	40 ^a	29 nC		
		0.0035 at $V_{GS} = 4.5 \text{ V}$	40 ^a	29110		

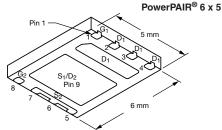
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFETs
- 100 % R_q and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Notebook System Power
- POL
- Synchronous Buck Converter





Ordering Information: SiZ910DT-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Channel-1	Channel-2	Unit	
Drain-Source Voltage		V_{DS}	30		V	
Gate-Source Voltage		V_{GS}	± 20		V	
Continuous Drain Current (T _J = 150 °C)	$T_C = 25 ^{\circ}\text{C}$ $T_C = 70 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$. I _D	40 ^a 40 ^a 22 ^{b, c}	40 ^a 40 ^a 32 ^{b, c}	A	
	T _A = 70 °C	<u> </u>	17 ^{b, c}	26 ^{b, c}		
Pulsed Drain Current (t = 300 μs)		I _{DM}	100	120		
Continuous Source Drain Diode Current	$T_C = 25 ^{\circ}C$ $T_A = 25 ^{\circ}C$	l _S	24 ^a 3.8 ^{b, c}	28 ^a 4.3 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	25	40		
Single Pulse Avalanche Energy	ne Energy		31	80	mJ	
	T _C = 25 °C		48	100	w	
Maximum Power Dissipation	T _C = 70 °C	P _D	31	64		
Maximum Power Dissipation	T _A = 25 °C		4.6 ^{b, c}	5.2 ^{b, c}		
	T _A = 70 °C		3 ^{b, c}	3.3 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		00	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		°C	

THERMAL RESISTANCE RATINGS								
			Char	nnel-1	Channel-2			
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	22	27	19	24	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	2.1	2.6	1	1.25	O/ VV	

Notes:

- a. Package limited T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 62 °C/W for channel-1 and 55 °C/W for channel-2.

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SPECIFICATIONS (T _J = 25 °							
Parameter	Symbol	Test Conditions		Min.	Тур.	Max.	Unit
Static	T		1	ı	1	_	1
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	Ch-1	30			V
	50	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	Ch-2	30			
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	$I_D = 250 \mu A$	Ch-1		33		mV/°C
TDS Temperature decimerent	2.08/.1	$I_D = 250 \mu A$	Ch-2		31		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$	Ch-1		- 5.4		1110/ C
VGS(th) Temperature document	△VGS(th)/ IJ	I _D = 250 μA	Ch-2		- 6.1		1
Gate Threshold Voltage	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	Ch-1	1.2		2.2	V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	Ch-2	1		2.2	V
Cata Cauraa Laakaga	lana	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	Ch-1			± 100	nA
Gate Source Leakage	I _{GSS}	VDS = 0 V, VGS = ± 20 V	Ch-2			± 100	IIA
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	Ch-1			1	
	L	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	Ch-2			1	μΑ
	IDSS	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	Ch-1			5	
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	Ch-2			5	
On-State Drain Current ^b		$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	Ch-1	20			<u> </u>
	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	Ch-2	25			A
	R _{DS(on)}	V _{GS} = 10 V, I _D = 20 A	Ch-1		0.0048	0.0058	
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	Ch-2		0.0025	0.0030	Ω
Drain-Source On-State Resistance ^b		V _{GS} = 4.5 V, I _D = 20 A	Ch-1		0.0060	0.0075	
		V _{GS} = 4.5 V, I _D = 20 A	Ch-2		0.0029	0.0035	
		V _{DS} = 10 V, I _D = 20 A	Ch-1		94		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 10 V, I _D = 20 A	Ch-2		140		S
Dynamic ^a		. 03			1	<u>l</u>	
Бупаппс			Ch-1	l	1500		
Input Capacitance	C _{iss}	Channel-1	Ch-2		3600		
		$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	Ch-1		285		pF
Output Capacitance	C _{oss}	Channel 0	Ch-2		660		
		Channel-2 $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	Ch-1		125		
Reverse Transfer Capacitance	C _{rss}		Ch-2		305		
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	Ch-1		26	40	nC
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	Ch-2		60	110	
Total Gate Charge	Qg	Channel-1 $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$ Channel-2	Ch-1		12.5	19	
			Ch-2		29	51	
Cata Carring Charge			Ch-1		4.7		
Gate-Source Charge	Q_{gs}		Ch-2		10		1
Cata Duain Chausa	Q _{gd}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$	Ch-1		4		
Gate-Drain Charge			Ch-2		9.5		
Gate Resistance	R_{g}	f = 1 MHz	Ch-1	0.5	2.6	5.2	Ω
Gato / Ioolotarioo	. 'g		Ch-2	0.1	0.6	1.2	22

Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.



Parameter Symbol		Test Conditions			Тур.	Max.	Unit
Dynamic ^a						•	
Turn-On Delay Time	t _{d(on)}	Channel-1	Ch-1		20	40	
•	2(21.)	$V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$	Ch-2		30	60	
Rise Time	t _r	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	Ch-1 Ch-2		25 35	50 70	
		Channel 0	Ch-1		25	50	
Turn-Off Delay Time	t _{d(off)}	Channel-2 $V_{DD} = 15 \text{ V}, R_{I} = 1.5 \Omega$	Ch-2		35	70	
Fall Time		$I_D \cong 10 \text{ A}, \ N_C = 1.3 \text{ S}^2$ $I_D \cong 10 \text{ A}, \ V_{GEN} = 4.5 \text{ V}, \ R_q = 1 \Omega$	Ch-1		10	20	
Fall Time	t _f	GEN 7 GEN 7 9	Ch-2		12	25	
Turn-On Delay Time	t.,,		Ch-1		10	20	ns
Turn-On Delay Time	t _{d(on)}	Channel-1	Ch-2		12	25	-
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_q = 1 Ω	Ch-1		25	25	
THISC THINC	4	D = 10 A, VGEN - 10 V, Hg - 122	Ch-2		12	25	
Turn-Off Delay Time $t_{d(off)} \hspace{1cm} Channel-2 \\ V_{DD} = 15 \text{ V, R}_{L} = 1.5 \ \Omega$	Channel-2	Ch-1		30	60		
	-u(oii)	V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω	Ch-2		35	70	
Fall Time	t _f		Ch-1		10	20	
			Ch-2		10	20	
Drain-Source Body Diode Characteristi	CS			ı	ı		1
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$	Ch-1 Ch-2			40	4
	I _{SM}		Ch-1			100	Α
Pulse Diode Forward Current ^a			Ch-2			120	
	V _{SD}	I _S = 10 A, V _{GS} = 0 V	Ch-1		0.8	1.2	
Body Diode Voltage		I _S = 10 A, V _{GS} = 0 V	Ch-2		0.8	1.2	V
			Ch-1		26	50	
Body Diode Reverse Recovery Time	t _{rr}		Ch-2		36	70	ns
De de Diede Deserve Deserve Observe	Q _{rr}	Channel-1 $I_F = 10$ A, $dI/dt = 100$ A/ μ s, $T_J = 25$ °C	Ch-1		25	50	20
Body Diode Reverse Recovery Charge			Ch-2		36	70	nC
Reverse Recovery Fall Time	t _a	Channel-2	Ch-1		17		
Tiovorso Hecovery Fair Time	° а	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	Ch-2		20		ns
Reverse Recovery Rise Time	t _b		Ch-1		9		110
. ic. c. c . icocvery i iico i iiiic			Ch-2		16		

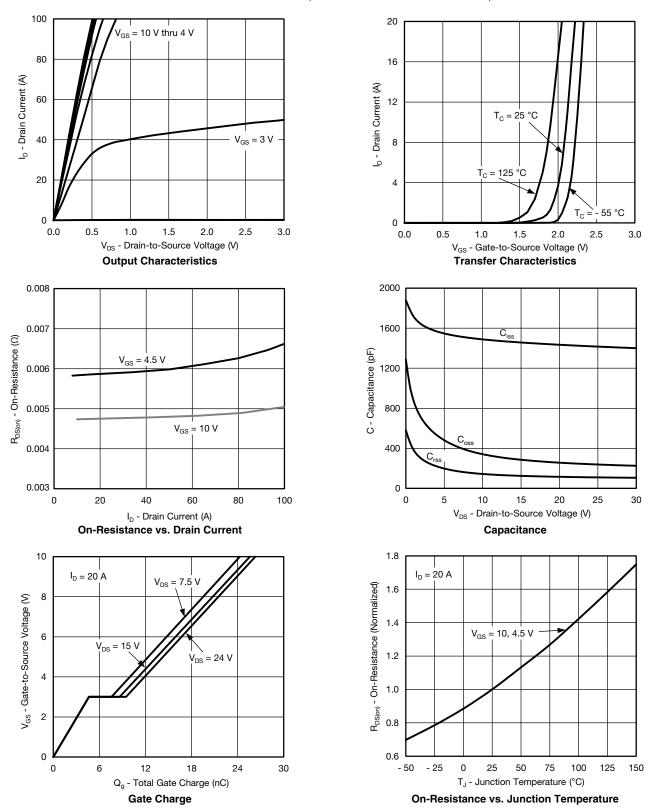
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

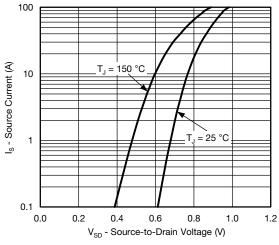
b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

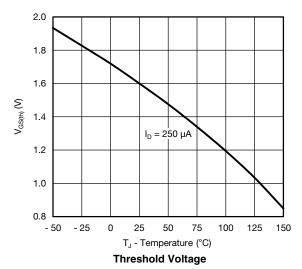


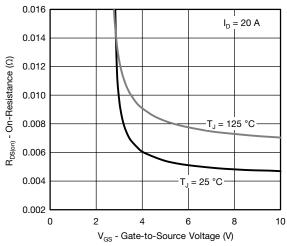


CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

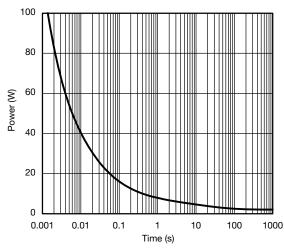


Source-Drain Diode Forward Voltage

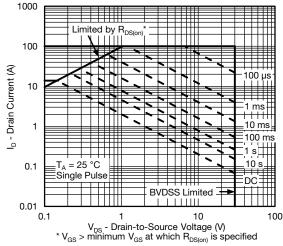




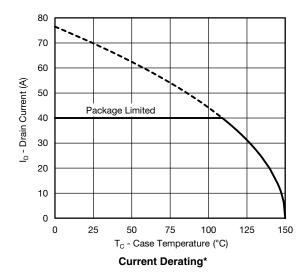
On-Resistance vs. Gate-to-Source Voltage

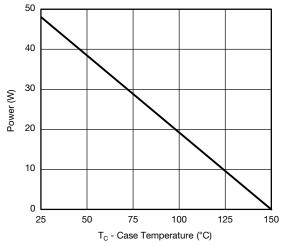


Single Pulse Power



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



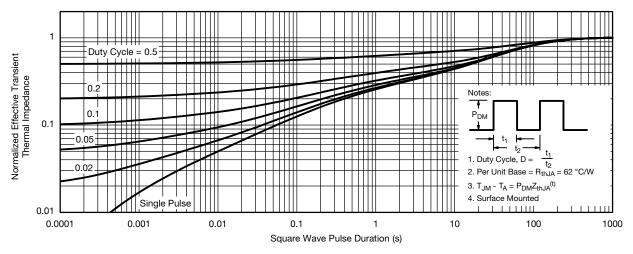


Power, Junction-to-Case

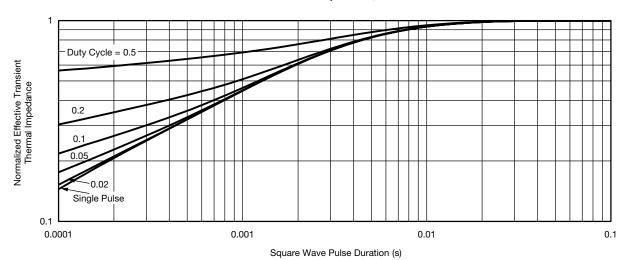
 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

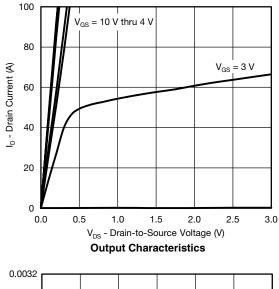


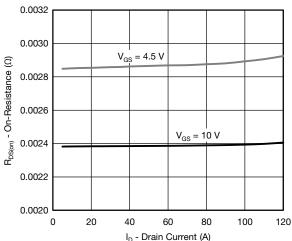
Normalized Thermal Transient Impedance, Junction-to-Ambient

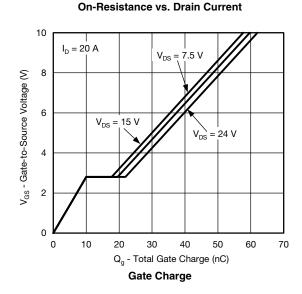


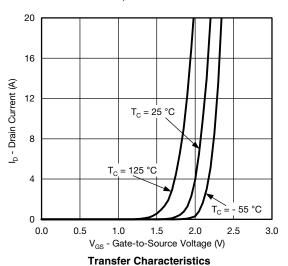
Normalized Thermal Transient Impedance, Junction-to-Case

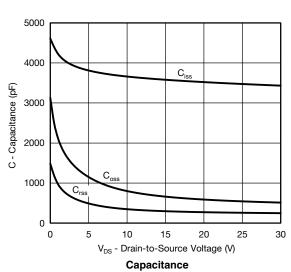
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

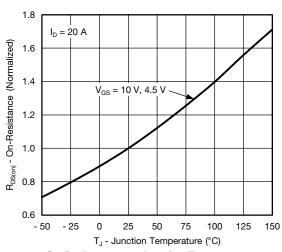








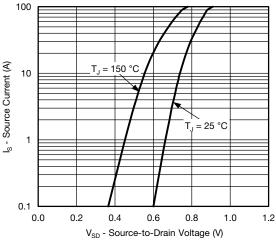




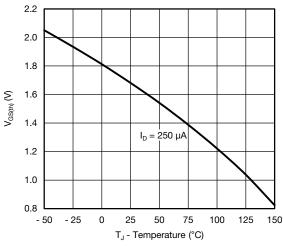




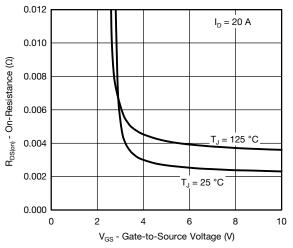
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



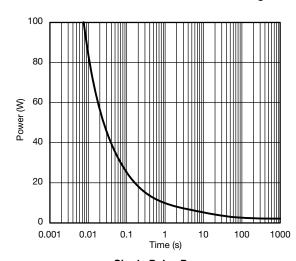
Source-Drain Diode Forward Voltage



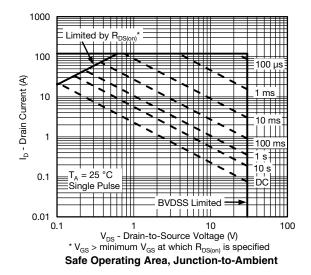
Threshold Voltage



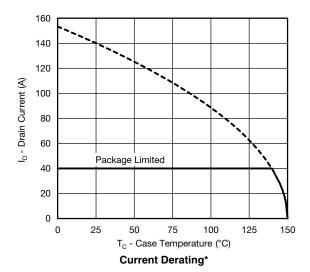
On-Resistance vs. Gate-to-Source Voltage

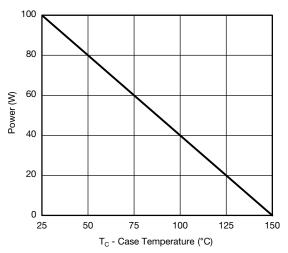


Single Pulse Power



CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

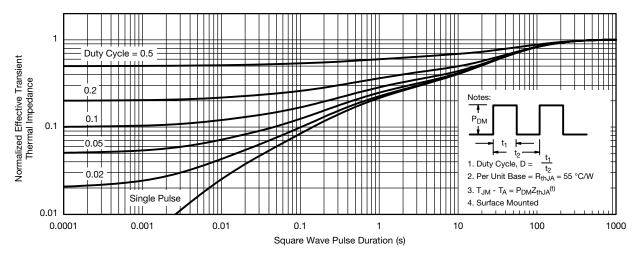




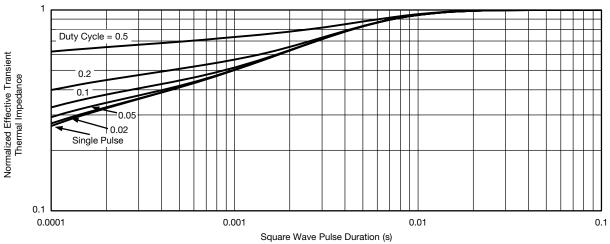
Power, Junction-to-Case

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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